

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10584408	YOSHINO ET AL.
Examiner	Art Unit	
Stephen M Hepperle	3753	

SEARCHED

Class	Subclass	Date	Examiner
137	501, 504	3/08	SMH

SEARCH NOTES

Search Notes	Date	Examiner
EAST, including citation search	3/08	SMH
PALM inventor search		

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner